THE UNITED STATES PATENT AND TRADEMARK OFFICE

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed together with the filing of a Request for Continued Examination (RCE) Application and before receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 18 Feb 2004

Attorney:

James E()Lake

Reg. No. 44,854

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AA 6,458,416	10/2002	Derderian						
AB 5,597,609	01/1997	Beisswenger et al						
AC 5,290,824	09/2001	Ishikawa et al						
AD 6,358,377	03/2002	Schloremberg et al						
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⊋artej S. Sandhu, et al.

Title:

Deposition Methods and Apparatuses Providing Surface Activation

Assignee:

Micron Technology, Inc.

Serial No.: 09/652,533

Filing Date: August 31, 2000

Docket No. MI22-1385

COPY FOR YOUR INFORMATION

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

attached form PTO-1449 is submitted compliance The in 37 CFR §1.56. No admission is made regarding whether any of the submitted references is prior art. Copies of the references are attached.

Citation of this reference is respectfully requested.

Respectfully submitted,

Dated: 17 Jul 2003

Reg. No. 44,854

Form PTO-1449			U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET N	SERI 09/65	SERIAL NO. 09/652,533			
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	AA	5,985,770	11/1999	Sandhu et	al						
	AB	5,281,274	1/1994	Yoder							
	AC	5,366,555	11/1994	Kelly	Kelly						
	AD	5,413,671	5/1995	Ketchum							
	AE	5,747,113	5/1998	Tsai							
	AF	6,306,216	10/2001	Kim et al							
	AG	5,116,640	5/1992	Mikami et :	al						
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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No
Confirmation No
Confirmation No
Inventor Gurtej S. Sandhu et al
Assignee
Group Art Unit
Examiner W. Brewster
Attorney's Docket No MI22-1385
Customer No
Title: Deposition Methods and Apparatuses Providing Surface Activation

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

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Citation of these references is respectfully requested.

Respectfully submitted,

Date: <u>i4Nov 2003</u> Attorney:

James E. Lake

Reg. No. 44,854

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	AB	6,143,659	11/2000	Leem							
	AC	6,330,201	10/2003	Chiang et	al						
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